

Dual 4-line to 1-line multiplexer

74F153

FEATURES

- Non-inverting outputs
- Separate enable for each section
- Common select inputs
- See 74F253 for 3-State version

DESCRIPTION

The 74F153 is a dual 4-input multiplexer that can select 2 bits of data from up to four sources selected by common Select inputs (S_0 , S_1). The two 4-input multiplexer circuits have individual active-Low Enables (E_a , E_b) which can be used to strobe the outputs independently. Outputs (Y_a , Y_b) are forced Low when the corresponding Enables (E_a , E_b) are High.

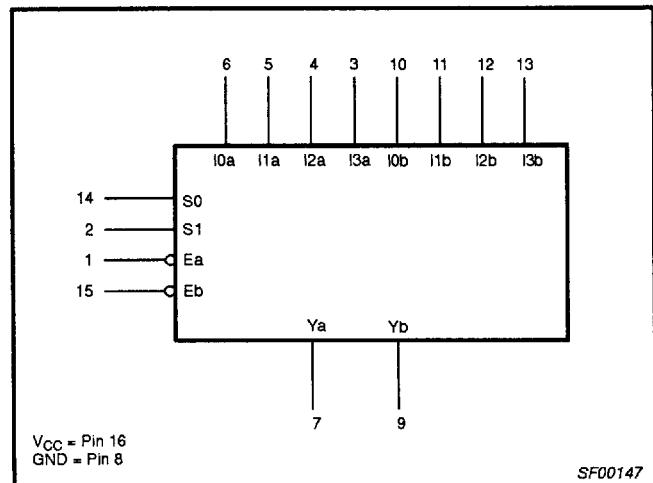
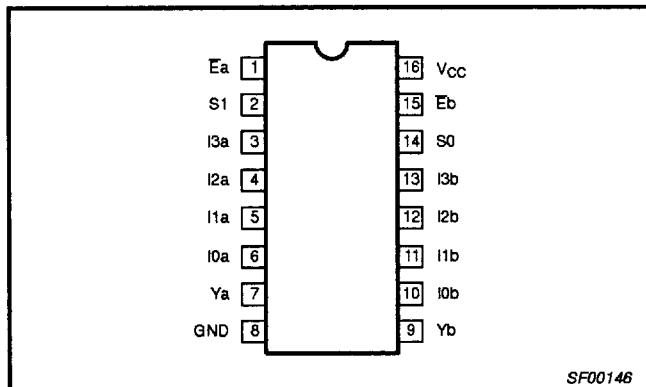
The 74F153 is the logic implementation of a 2-pole, 4-position switch where the switch is determined by the logic levels supplied to the common select inputs.

TYPE	TYPICAL PROPAGATION DELAY	TYPICAL SUPPLY CURRENT (TOTAL)
74F153	7.0ns	12mA

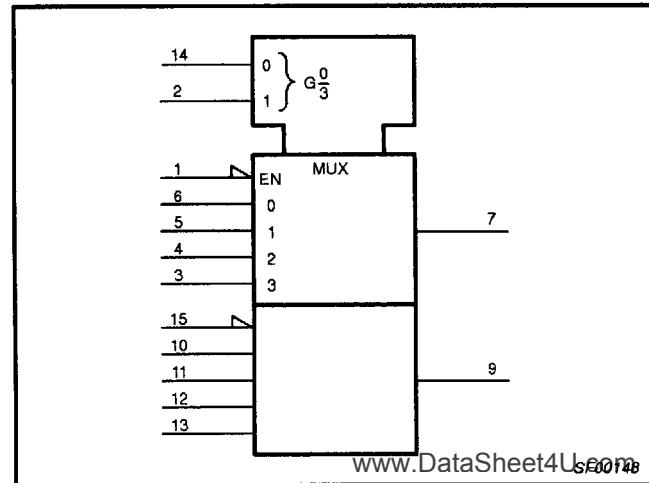
INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F (U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
I_{0a} - I_{3a}	Port A data inputs	1.0/1.0	20 μ A/0.6mA
I_{0b} - I_{3b}	Port B data inputs	1.0/1.0	20 μ A/0.6mA
S_0 , S_1	Common Select inputs	1.0/1.0	20 μ A/0.6mA
E_a	Port A Enable input (active Low)	1.0/1.0	20 μ A/0.6mA
E_b	Port B Enable input (active Low)	1.0/1.0	20 μ A/0.6mA
Y_a , Y_b	Port A, B data outputs	50/33	1.0 μ A/20mA

NOTE: One (1.0) FAST unit load is defined as: 20 μ A in the High state and 0.6mA in the Low state.

LOGIC SYMBOL**PIN CONFIGURATION****ORDERING INFORMATION**

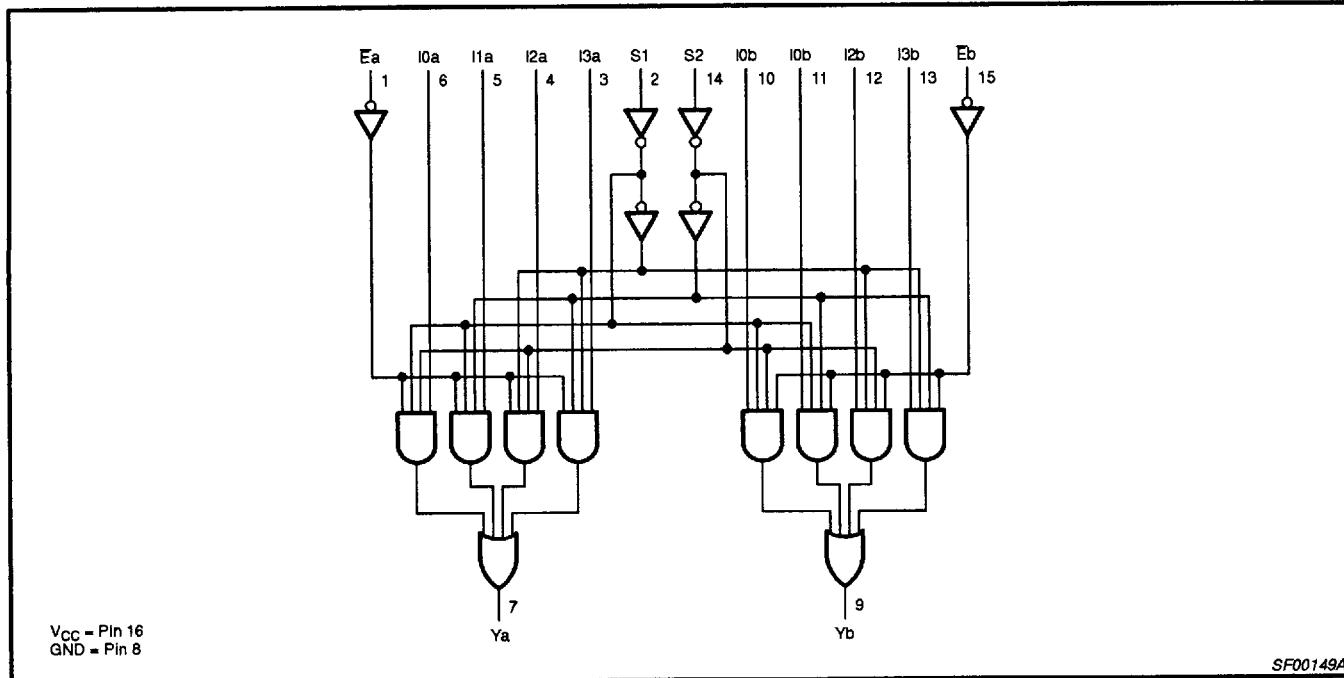
DESCRIPTION	COMMERCIAL RANGE $V_{CC} = 5V \pm 10\%$, $T_{amb} = 0^\circ C$ to $+70^\circ C$	PKG. DWG. #
16-pin plastic DIP	N74F153N	SOT38-4
16-pin plastic SO	N74F153D	SOT162-1

IEC/IEEE SYMBOL

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LOGIC DIAGRAM



FUNCTION TABLE

INPUTS							OUTPUT
S ₀	S ₁	E _n	I0n	I1n	I2n	I3n	Y _n
X	X	H	X	X	X	X	L
L	L	L	L	X	X	X	L
L	L	L	H	X	X	X	H
H	L	L	X	L	X	X	L
H	L	L	X	H	X	X	H
L	H	L	X	X	L	X	L
L	H	L	X	X	H	X	H
H	H	L	X	X	X	L	L
H	H	L	X	X	X	H	H

H = High voltage level

L = Low voltage level

X = Don't care

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ABSOLUTE MAXIMUM RATINGS

(Operation beyond the limits set forth in this table may impair the useful life of the device.
Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER	RATING	UNIT
V _{CC}	Supply voltage	-0.5 to +7.0	V
V _{IN}	Input voltage	-0.5 to +7.0	V
I _{IN}	Input current	-30 to +5	mA
V _{OUT}	Voltage applied to output in High output state	-0.5 to V _{CC}	V
I _{OUT}	Current applied to output in Low output state	40	mA
T _{amb}	Operating free-air temperature range	0 to +70	°C
T _{stg}	Storage temperature range	-65 to +150	°C

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIMITS			UNIT
		MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5.0	5.5	V
V _{IH}	High-level input voltage	2.0			V
V _{IL}	Low-level input voltage			0.8	V
I _{IK}	Input clamp current			-18	mA
I _{OH}	High-level output current			-1	mA
I _{OL}	Low-level output current			20	mA
T _{amb}	Operating free-air temperature range	0		+70	°C

DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

SYMBOL	PARAMETER	TEST CONDITIONS ¹		LIMITS			UNIT	
				MIN	Typ ²	MAX		
V _{OH}	High-level output voltage	V _{CC} = MIN, V _{IL} = MAX	±10%V _{CC}	2.5			V	
		V _{IH} = MIN, I _{OH} = MAX	±5%V _{CC}	2.7	3.4			
V _{OL}	Low-level output voltage	V _{CC} = MIN, V _{IL} = MAX	±10%V _{CC}		0.30	0.50	V	
		V _{IH} = MIN, I _{OL} = MAX	±5%V _{CC}		0.30	0.50		
V _{IK}	Input clamp voltage	V _{CC} = MIN, I _I = I _{IK}			-0.73	-1.2	V	
I _I	Input current at maximum input voltage	V _{CC} = MAX, V _I = 7.0V				100	µA	
I _{IH}	High-level input current	V _{CC} = MAX, V _I = 2.7V				20	µA	
I _{IL}	Low-level input current	V _{CC} = MAX, V _I = 0.5V				-0.6	mA	
I _{OS}	Short-circuit output current ³	V _{CC} = MAX		-60		-150	mA	
I _{CC}	Supply current (total)	I _{CCH}	V _{CC} = MAX	En = GND, Sn=In=4.5V		12	20	mA
		I _{CCL}		En=Sn=In=GND		12	20	

NOTES:

- For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions for the applicable type.
- All typical values are at V_{CC} = 5V, T_{amb} = 25°C.
- Not more than one output should be shorted at a time. For testing I_{OS}, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

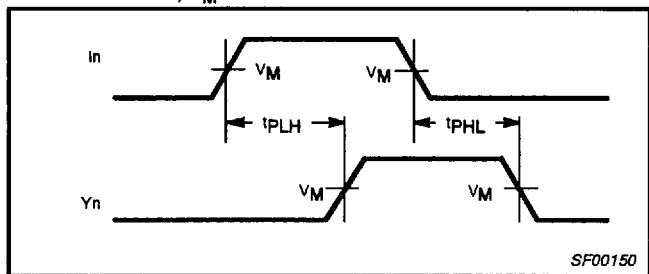
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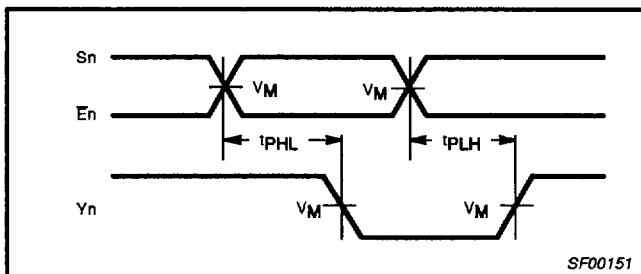
AC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITION	LIMITS					UNIT	
			$V_{CC} = +5.0V$			$V_{CC} = +5.0V \pm 10\%$			
			MIN	TYP	MAX	MIN	MAX		
t_{PLH} t_{PHL}	Propagation delay In to Y_n	Waveform 1	3.0 3.0	4.5 5.0	7.0 7.5	2.5 2.5	8.0 8.0	ns	
t_{PLH} t_{PHL}	Propagation delay Sn to Y_n	Waveform 2	5.0 5.0	8.0 8.0	10.5 10.5	4.5 4.5	12.0 12.0	ns	
t_{PLH} t_{PHL}	Propagation delay En to Y_n	Waveform 2	5.0 4.0	7.5 5.5	9.0 7.0	4.5 3.5	10.5 8.0	ns	

AC WAVEFORMS

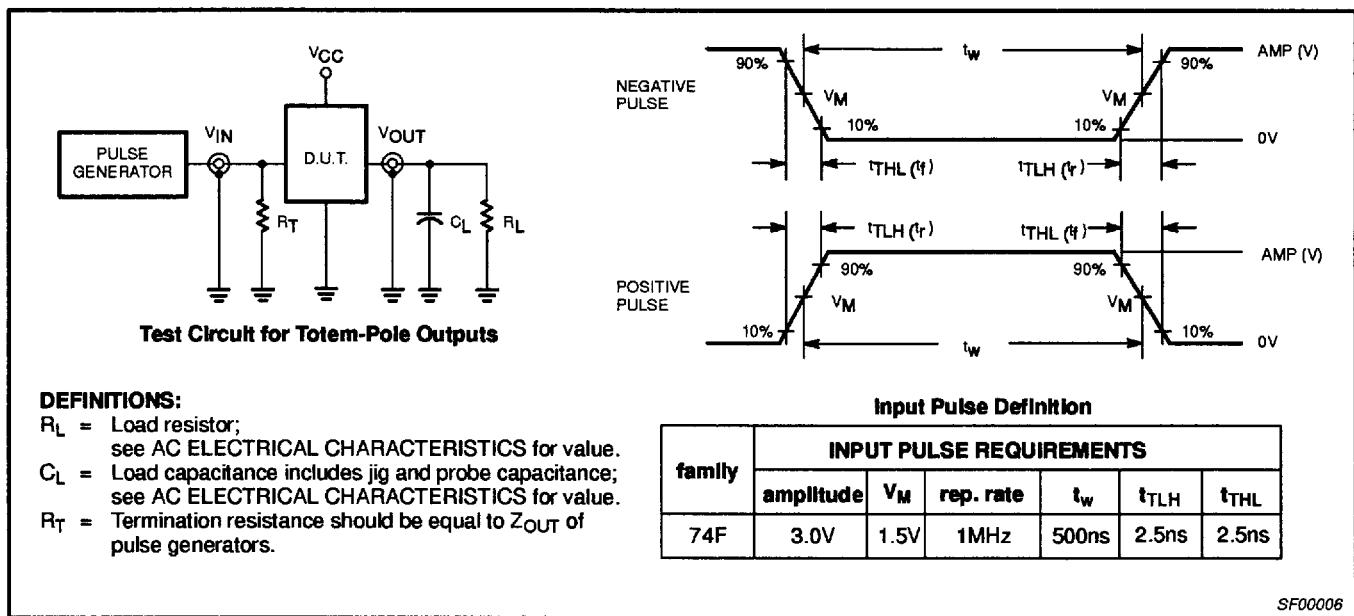
For all waveforms, $V_M = 1.5V$.

Waveform 1. Propagation Delay, Data to Output



Waveform 2. Propagation Delay, Enable and Select to Output

TEST CIRCUIT AND WAVEFORMS



DEFINITIONS:

 R_L = Load resistor;

see AC ELECTRICAL CHARACTERISTICS for value.

 C_L = Load capacitance includes jig and probe capacitance;
see AC ELECTRICAL CHARACTERISTICS for value. R_T = Termination resistance should be equal to Z_{OUT} of
pulse generators.